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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/716,250	DENG ET AL.	
Examiner	Art Unit	
Dao H. Nguyen	2818	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT; USPG-PUB; EPO; JPO; IBM-TDB; USOCAR, DERWENT)	2/14/2007	DN
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